

Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

| Characteristic | Symbol | Value | Unit |
|--|------------------|------------------------|------|
| Drain-Source Voltage | V _{DSS} | 30 | V |
| Gate-Source Voltage | V _{GSS} | +20 -16 | V |
| Continuous Drain Current, V _{GS} = 10V (Note 5) | I _D | T _A = +25°C | 22 |
| | | T _A = +70°C | 18 |
| Continuous Drain Current, V _{GS} = 10V | I _D | T _C = +25°C | 145 |
| | | T _C = +70°C | 120 |
| Maximum Continuous Body Diode Forward Current (Note 5) | I _S | 3 | A |
| Pulsed Drain Current (10μs Pulse, Duty Cycle = 1%) | I _{DM} | 180 | A |
| Avalanche Current, L=0.3mH | I _{AS} | 27 | A |
| Avalanche Energy, L=0.3mH | E _{AS} | 110 | mJ |

Thermal Characteristics

| Characteristic | Symbol | Value | Unit |
|--|-----------------------------------|---------------------------------|------|
| Total Power Dissipation | P _D | T _A = +25°C (Note 5) | 3.2 |
| | | T _C = +25°C | 136 |
| Thermal Resistance, Junction to Ambient (Note 5) | R _{θJA} | 47 | °C/W |
| Thermal Resistance, Junction to Case | R _{θJC} | 1.1 | |
| Operating and Storage Temperature Range | T _J , T _{STG} | -55 to +175 | °C |

Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

| Characteristic | Symbol | Min | Typ | Max | Unit | Test Condition |
|---|---------------------|-----|------|------|------|--|
| OFF CHARACTERISTICS (Note 6) | | | | | | |
| Drain-Source Breakdown Voltage | BV _{DSS} | 30 | — | — | V | V _{GS} = 0V, I _D = 250μA |
| Zero Gate Voltage Drain Current | I _{DSS} | — | — | 1 | μA | V _{DS} = 24V, V _{GS} = 0V |
| Gate-Source Leakage | I _{GSS} | — | — | ±100 | nA | V _{GS} = +20V, V _{DS} = 0V V _{GS} = -16V, V _{DS} = 0V |
| ON CHARACTERISTICS (Note 6) | | | | | | |
| Gate Threshold Voltage | V _{GS(TH)} | 1 | — | 3 | V | V _{DS} = V _{GS} , I _D = 250μA |
| Static Drain-Source On-Resistance | R _{DS(ON)} | — | 3.3 | 3.8 | mΩ | V _{GS} = 10V, I _D = 20A |
| | | — | 5 | 6 | | V _{GS} = 4.5V, I _D = 7A |
| Diode Forward Voltage | V _{SD} | — | 0.70 | 1 | V | V _{GS} = 0V, I _S = 1A |
| DYNAMIC CHARACTERISTICS (Note 7) | | | | | | |
| Input Capacitance | C _{iSS} | — | 2370 | — | pF | V _{DS} = 15V, V _{GS} = 0V, f = 1MHz |
| Output Capacitance | C _{oss} | — | 1360 | — | | |
| Reverse Transfer Capacitance | C _{rSS} | — | 240 | — | | |
| Gate Resistance | R _g | — | 0.7 | — | Ω | V _{DS} = 0V, V _{GS} = 0V, f = 1MHz |
| Total Gate Charge (V _{GS} = 10V) | Q _g | — | 43.7 | — | nC | V _{DS} = 15V, I _D = 20A |
| Gate-Source Charge | Q _{gs} | — | 6.9 | — | | |
| Gate-Drain Charge | Q _{gd} | — | 8 | — | | |
| Turn-On Delay Time | t _{D(ON)} | — | 6.2 | — | ns | V _{DD} = 15V, V _{GS} = 10V, R _G = 3Ω, R _L = 0.75Ω |
| Turn-On Rise Time | t _R | — | 4.2 | — | | |
| Turn-Off Delay Time | t _{D(OFF)} | — | 21 | — | | |
| Turn-Off Fall Time | t _F | — | 8 | — | | |
| Body Diode Reverse Recovery Time | t _{RR} | — | 25 | — | ns | I _F = 15A, di/dt = 500A/μs |
| Body Diode Reverse Recovery Charge | Q _{RR} | — | 37 | — | | |

- Notes:
- R_{θJA} is determined with the device mounted on FR-4 substrate PC board, 2oz copper, with 1in. square copper plate. R_{θJC} is guaranteed by design while R_{θJA} is determined by the user's board design.
 - Short duration pulse test used to minimize self-heating effect.
 - Guaranteed by design. Not subject to product testing.

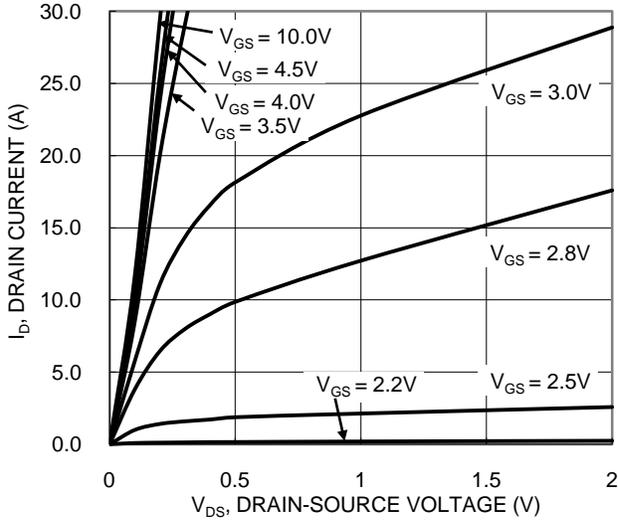


Figure 1. Typical Output Characteristic

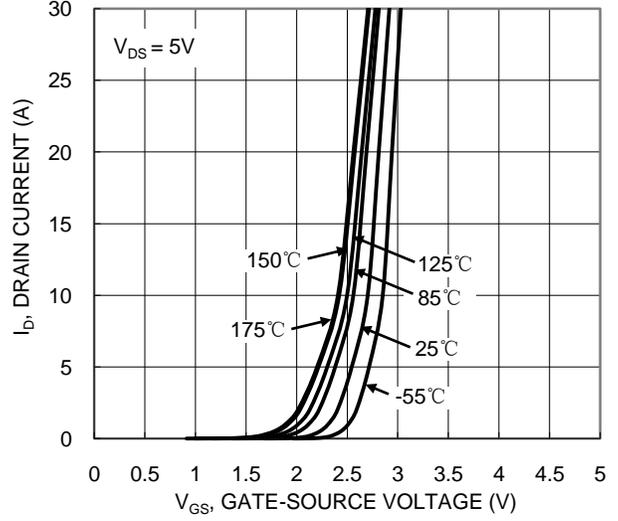


Figure 2. Typical Transfer Characteristic

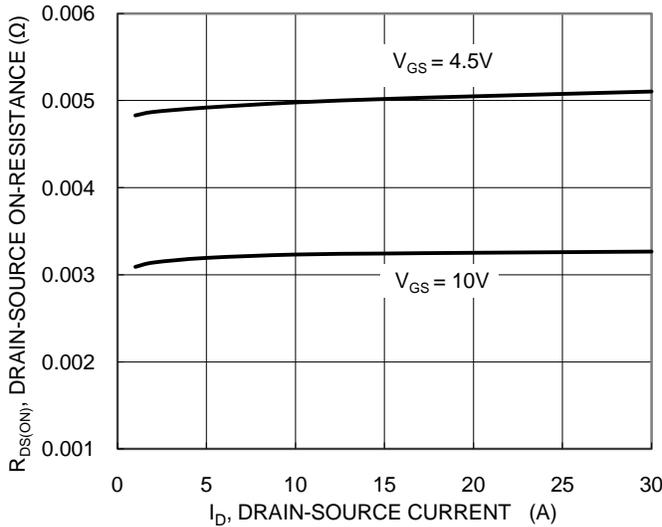


Figure 3. Typical On-Resistance vs. Drain Current and Gate Voltage

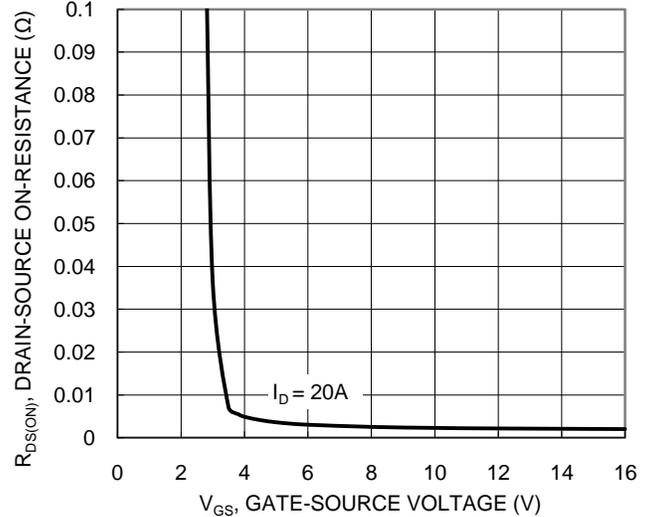


Figure 4. Typical Transfer Characteristic

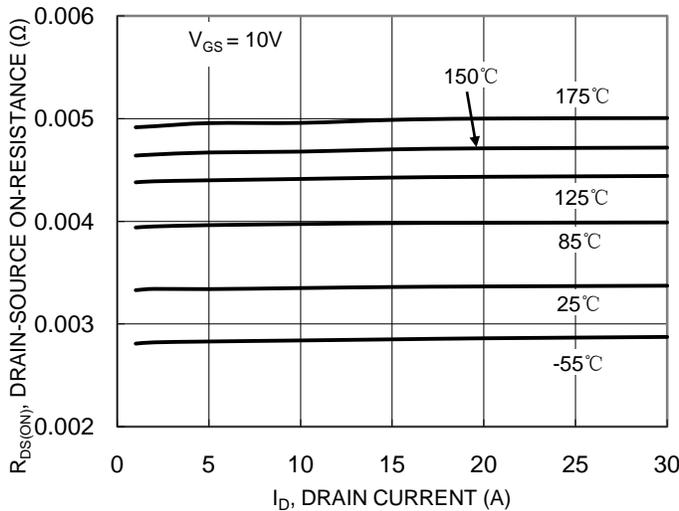


Figure 5. Typical On-Resistance vs. Drain Current and Junction Temperature

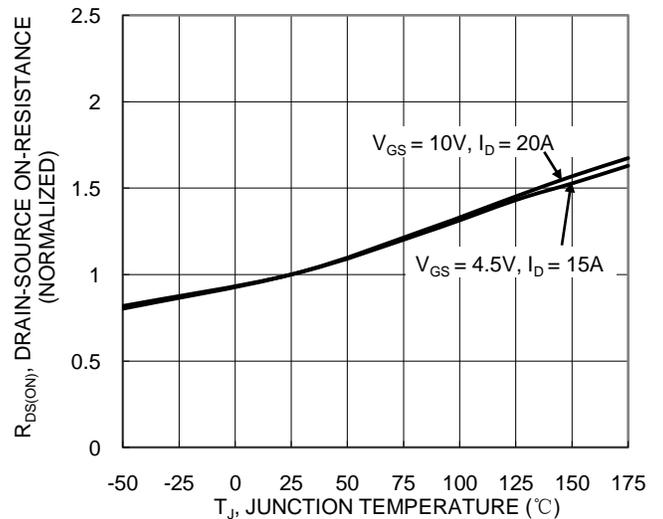


Figure 6. On-Resistance Variation with Junction Temperature

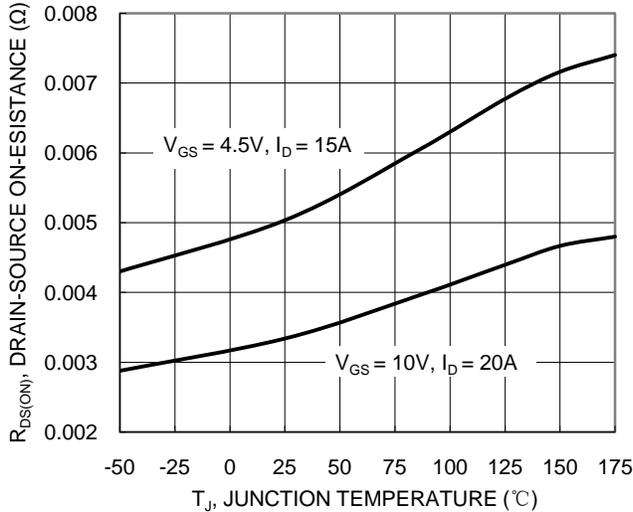


Figure 7. On-Resistance Variation with Junction Temperature

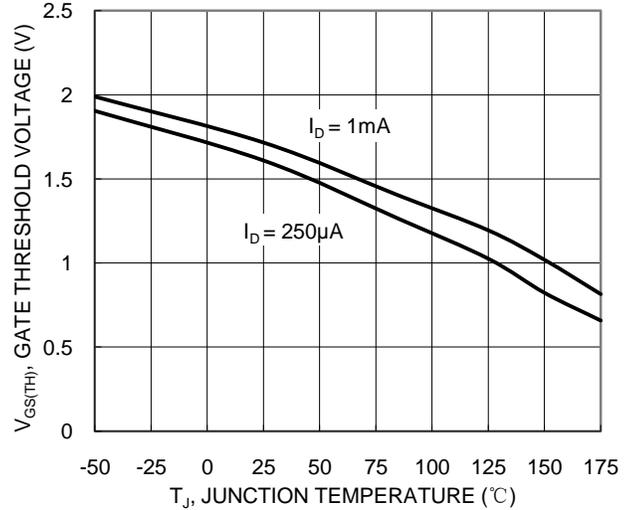


Figure 8. Gate Threshold Variation vs. Junction Temperature

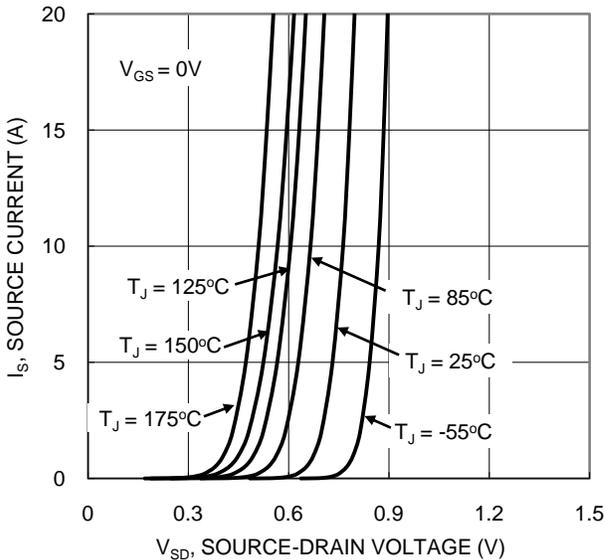


Figure 9. Diode Forward Voltage vs. Current

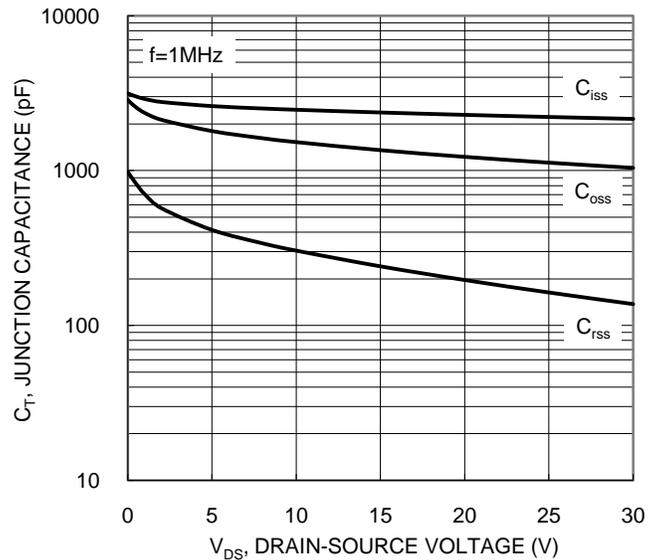


Figure 10. Typical Junction Capacitance

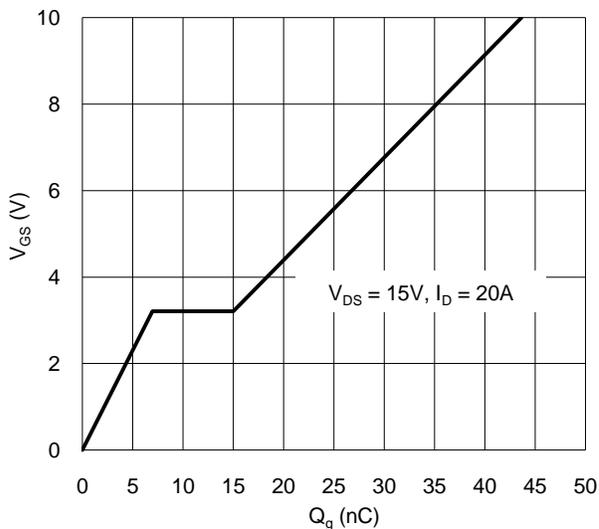


Figure 11. Gate Charge

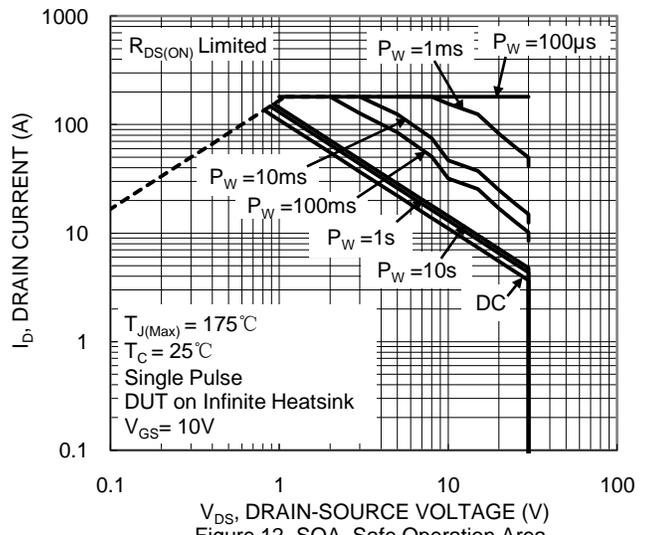


Figure 12. SOA, Safe Operation Area

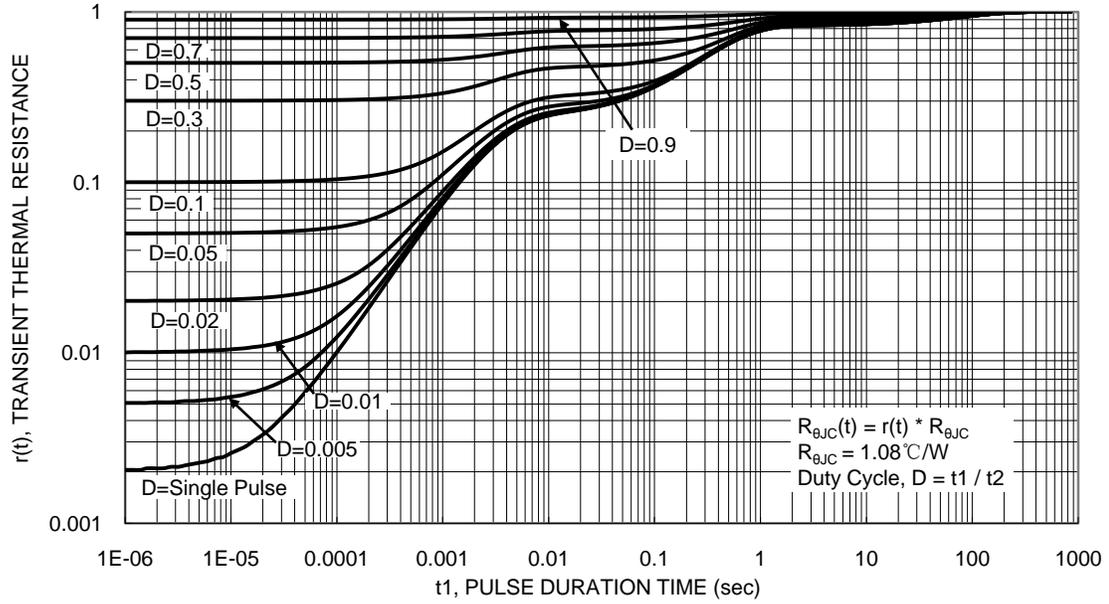
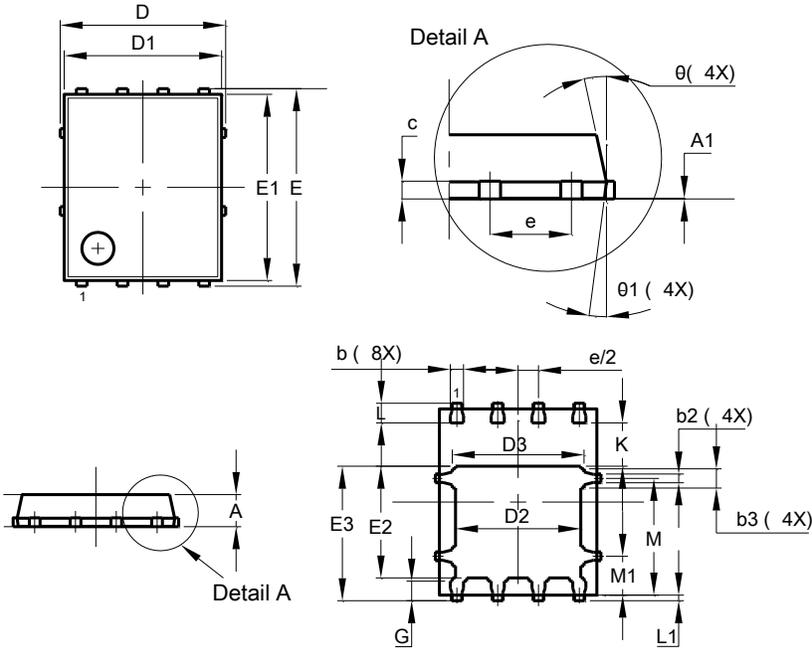


Figure 13. Transient Thermal Resistance

Package Outline Dimensions

Please see AP02002 at <http://www.diodes.com/datasheets/ap02002.pdf> for the latest version.

POWERDI[®] 5060-8

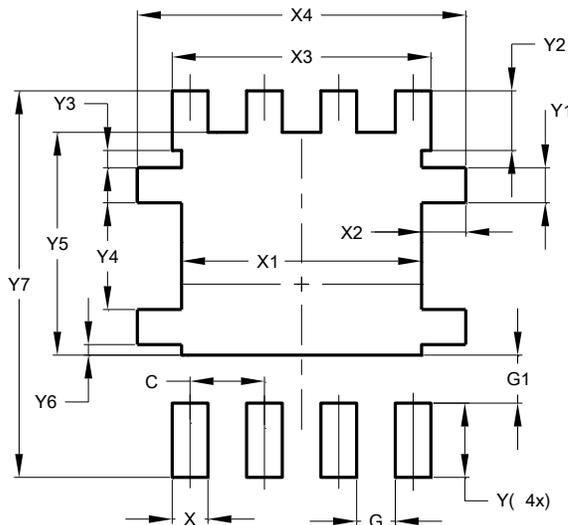


| POWERDI [®] 5060-8 | | | |
|-----------------------------|----------|-------|-------|
| Dim | Min | Max | Typ |
| A | 0.90 | 1.10 | 1.00 |
| A1 | 0.00 | 0.05 | — |
| b | 0.33 | 0.51 | 0.41 |
| b2 | 0.200 | 0.350 | 0.273 |
| b3 | 0.40 | 0.80 | 0.60 |
| c | 0.230 | 0.330 | 0.277 |
| D | 5.15 BSC | | |
| D1 | 4.70 | 5.10 | 4.90 |
| D2 | 3.70 | 4.10 | 3.90 |
| D3 | 3.90 | 4.30 | 4.10 |
| E | 6.15 BSC | | |
| E1 | 5.60 | 6.00 | 5.80 |
| E2 | 3.28 | 3.68 | 3.48 |
| E3 | 3.99 | 4.39 | 4.19 |
| e | 1.27 BSC | | |
| G | 0.51 | 0.71 | 0.61 |
| K | 0.51 | — | — |
| L | 0.51 | 0.71 | 0.61 |
| L1 | 0.100 | 0.200 | 0.175 |
| M | 3.235 | 4.035 | 3.635 |
| M1 | 1.00 | 1.40 | 1.21 |
| θ | 10° | 12° | 11° |
| θ1 | 6° | 8° | 7° |
| All Dimensions in mm | | | |

Suggested Pad Layout

Please see AP02001 at <http://www.diodes.com/datasheets/ap02001.pdf> for the latest version.

POWERDI[®] 5060-8



| Dimensions | Value (in mm) |
|------------|---------------|
| C | 1.270 |
| G | 0.660 |
| G1 | 0.820 |
| X | 0.610 |
| X1 | 4.100 |
| X2 | 0.755 |
| X3 | 4.420 |
| X4 | 5.610 |
| Y | 1.270 |
| Y1 | 0.600 |
| Y2 | 1.020 |
| Y3 | 0.295 |
| Y4 | 1.825 |
| Y5 | 3.810 |
| Y6 | 0.180 |
| Y7 | 6.610 |

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